RS5N65F

VDSS

650V

N Channel MOSFET

Applications:

- •Adapter & Charger
- •AC-DC Switching Power Supply
- LED driving power
- •PC Power Supply

Features:

- •100% avalanche tested
- •Ultra low gate Charge(typical 14nC)
- •Low Cress(typical 5.4pF)
- •Fast switching capability
- •RoHS Compliant

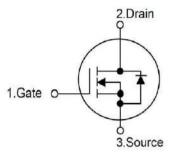
Ordering Information

Part Number	Package	Marking
RS5N65F	TO-220F	RS5N65F



lр

5A



Lead Free Package and Finish

Not to Scale

(96)

RDS(ON)(Typ.)

1.9Ω

Absolute Maximun Ratings Tc=25°C unless otherwise specified

Symbol	Parameter	RS5N65F	Units
VDSS	Drain-to-Source Voltage (Note*1)	650	V
ID	Continuous Drain Current	5	
ID@ 100 ℃	Continuous Drain Current	3.2	A
ldм	Pulsed Drain Current (Note*2)	20	
DD	Power Dissipation	38	W
PD	Derating Factor above 25℃	0.3	W/°C
VGS	Gate-to-Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L=29mH IAS=5A VDD=50V RG=25Ω TJ=25℃	232	mJ
EAR	Repetitve Pulse Avalanche Engergy (pulse width limied by maximum junction temperature)	15	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds	300 260	ĉ
	Package Body for 10 seconds		C
TJ and TSTG	Operating Junction and Storage	-55 to 150	
	Temperature Range	-33 10 130	

*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS5N65F	Units	Test Conditions
Rejc	Junction-to-Case	3.29	°C/W	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150℃.
Reja	Junction-to-Ambient	120		1 cubic foot chamber, free air.

OFF Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter		Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	650			V	Vgs=0V,Id=250µA
ldss	Drain-to-Source Leakage Current			1.0	μA	VDS=650V,VGS=0V
	Gate-to-Source Forward Leakage	kage		100	n۸	VGS=+30V VDS=0V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	VGS=-30V VDS=0V

ON Characteristics TJ=25℃ unless otherwise specified

Symbol	Parameter		Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain-to-Source On-Resistance		1.90	2.40	Ω	VGS=10V,ID=2.5A
Vgs(TH)	Gate Threshold Voltage			4.0	V	Vgs=Vds,Id=250µA
Gfs	Forward Transconductance		2.5		S	VDS=50V,ID=2.5A

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		15			VDS=325V ID=5A RG=10Ω (Note:3,4)
trise	Rise Time		30		nS	
td(OFF)	Turn-OFF Delay Time		20		110	
tfall	Fall Time		14			

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		570			Vgs=0V
Coss	Output Capacitance		56		pF	VDS=25V
Crss	Reverse Transfer Capacitance		5.4			f=1.0MHz
Qg	Total Gate Charge		14			VDS=520V
Qgs	Gate-to-Source Charge		3.8		nC	ID=5A VGS=10V (Note:3,4)
Qgd	Gate-to-Drain("Miller") Charge		7.5			



Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current			5	Α	Integral pn-diode
Ism	Maximum Pulsed Current			20	Α	in MOSFET
Vsd	Diode Forward Voltage			1.4	V	Is=5A,Vgs=0V
trr	Reverse Recovery Time		513		nS	Vgs=0V
Qrr	Reverse Recovery Charge		2.6		μC	Is=5A,di/dt=100A/µs

Notes:

*1.TJ=±25℃ to +150℃.

*2.Repetitive rating; pulse width limited by maximum junction temperature.

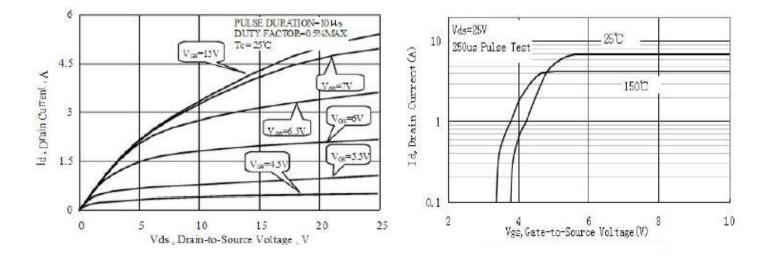
*3.Pulse width \leq 300µs; duty cycle \leq 2%.

*4.Basically not affected by temperature.

Typical Feature curve

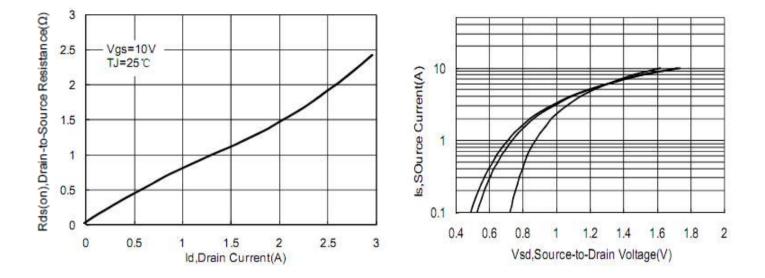
Figure1.TypicalOutput Characteistics

Figure2.Typical Transfer Characteristics





RS5N65F



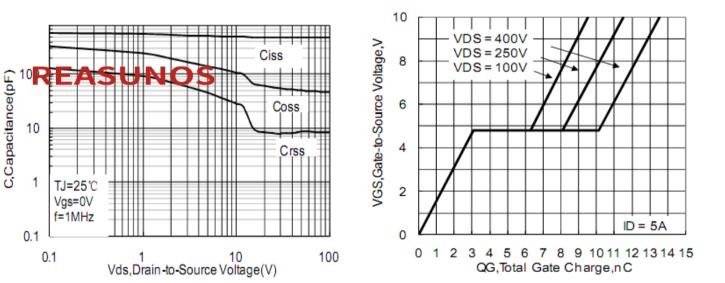
Figuer3.Typical ON Resistance vs Drain Current

Figure5.Typical Capacitance vs Drainto-Source Voltage

Figure6.Typical Gate Charge vs Gateto-Source Voltage

Figuer4.Typical Body Diode Transfer

Characteristics





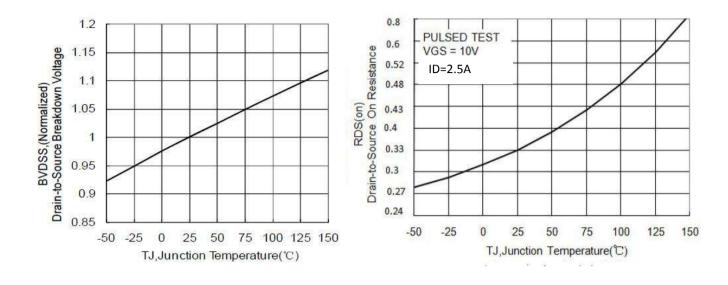
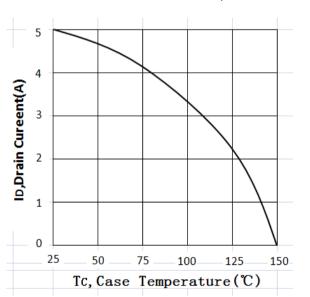


Figure7. Typical Breakdown Voltage vs Junation Temperature



Figure9.Maximum Continuous Drain Current vs Case Temperature

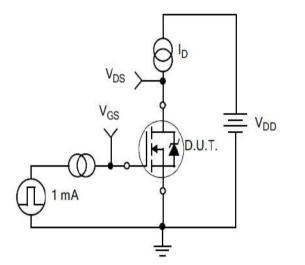
Figure10.Maximum Safe Operating Area



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Test Circuits and Waveforms



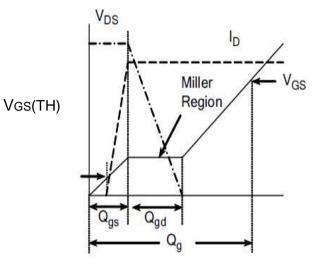


Figure11. Gate Charge Test Circuit

Figure12. Gate Charge Waveform

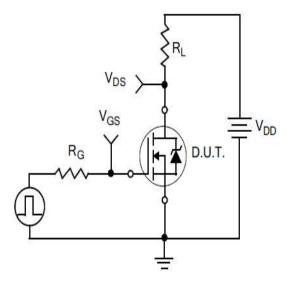


Figure13. Resistive Switching Test Circuit

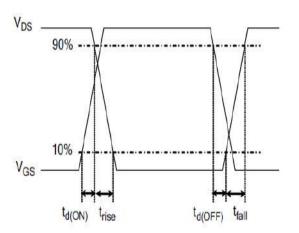


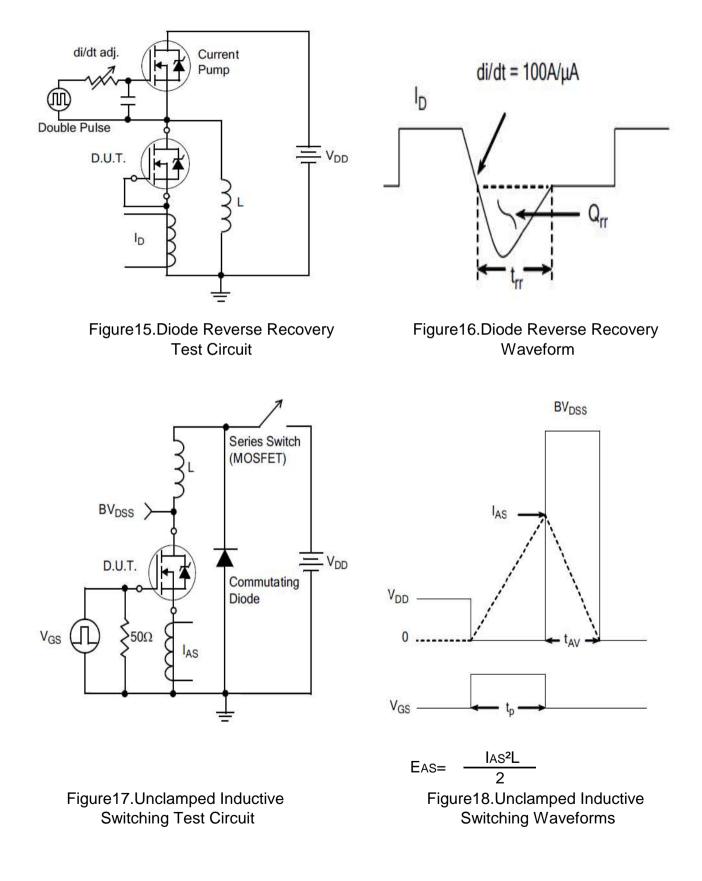
Figure14. Resistive Switching Waveforms

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RS5N65F

Test Circuits and Waveforms

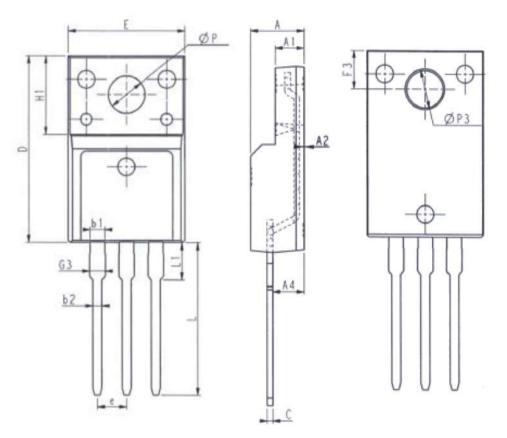




Package outline drawing

Unit:mm

TO-220F



Unit: mm			Unit: mm			
Symbol	Min.	Max.	Symbol	Min.	Max.	
E	9.96	10.36	L	12. 68	13.28	
A	4.50	4.90	L1	2.93	3.13	
A1	2.34	2.74	P	3.03	3.38	
A2	0.30	0.60	P3	3.15	3.65	
A4	2.56	2.96	F3	3. <mark>1</mark> 5	3.45	
С	0.40	0.65	G3	1.25	1.55	
D	15.57	16.17	b1	1.18	1.43	
H1	6. 70	OREF	b2	0.70	0.95	
e	2. 54	4BSC	63 			

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